

CMR Institute of Technology Department of ECE 21EC62 – Microwave Theory & Antennas 2 nd IAT Scheme & Solutions – July 2024

INTERNAL ASSESSMENT TEST – II

Answer any 5 full questions

1. Properties of Scattering Matrix

$6.3.1$ Properties of S-Parameters

 $\frac{\hbar^{3}}{\hbar^{2}}$ eneral the scattering parameters are complex quantities having the following In general set of different characteristics of the microwave network.

 $\frac{p}{a}$ (a) Zero diagonal elements for perfect matched network

For an ideal N-port network with matched termination, $S_{ii} = 0$, since there is no For an $x = 0$, since there is no
reflection from any port. Therefore, under perfect matched conditions the diago- $_{\text{nal}}$ elements of [S] are zero.

(b) Symmetry of $[S]$ for a reciprocal network

A reciprocal device has the same transmission characteristics in either direction of a pair of ports and is characterised by a symmetric scattering matrix,

$$
S_{ij} = S_{ji} \left(i \neq j \right) \tag{6.25}
$$

146 Microway hich resume $[S]_t = [S]$
 $[S]_t = [S]$
 $[S]_t = [S]$
 $[S]_t = [S]$
 $[S]_t = [S]_t$
 $[S]_t = [S]_$ This condition can be proved in the impedance matrix equation is

This condition can be proved in the impedance matrix equation is

work with the assumed normalisation, $[L] = [Z]$ ($[a] - [b]$) = $[a] + [b]$ $([Z] + [U]) [b] = ([Z] - [U]) [a]$ $[b] = ([Z] + [U])^{-1} ([Z] - [U]) [a]$ or, where [U] is the unit matrix. The S-matrix equation for the network is $(6,2)$ (6.2) $[b] = \left[\mathit{S} \right] \left[\mathit{a} \right]$ Comparing Eqs 6.27 and 6.28, we have $\left[\begin{matrix}S\end{matrix}\right]=\left(\left[\begin{matrix}Z\end{matrix}\right]+\left[\begin{matrix}U\end{matrix}\right]\right)^{-1}\left(\left[\begin{matrix}Z\end{matrix}\right]-\left[\begin{matrix}U\end{matrix}\right]\right)$ (6.2) $[R] = [Z] - [U], [Q] = [Z] + [U]$ (6.3) For reciprocal network, the Z-matrix is symmetric. Hence Let $[R] [Q] = [Q] [R]$ $[Q]^{-1}[R][Q][Q]^{-1} = [Q]^{-1}[Q][R][Q]^{-1}$ or. $[Q]^{-1}[R] = S = [R][Q]^{-1}$ (6.3) or, Now the transpose of $[S]$ is $[S]_t = ([Z] - [U])_t ([Z] + [U])_t^{-1}$ (6.32) Since the Z-matrix is symmetrical $([Z] - [U])$, = [Z] - [U] (6.33) $([Z] + [U])$, = [Z] + [U] (6.34) Therefore, $[S]_t = ([Z] - [U]) ([Z] + [U])^{-1}$ $=[R][Q]^{-1}=[S]$ (6.35) Thus it is proved that $[S]_t = [S]$, for a symmetrical junction. (c) Unitary property for a lossless junction For any lossless network the sum of the products of each term of any one row of θ any column of the S-matrix multiple products of each term of any one row of θ any column of the S-matrix multiplied by its complex conjugate is unity-
For a lossless n-nort devices in plied by its complex conjugate is unity-For a lossless *n*-port device, the total power leaving *N*-ports must be equally total power input to these north and power leaving *N*-ports must be equally the total power input to these ports, so that $\sum_{n=1}^{N} |b_n|^2 = \sum_{n=1}^{N} |a_n|^2$

Microwave Network Theory and Passive Devices 147

$$
\sum_{n=1}^{N} \left| \sum_{i=1}^{n} S_{ni} a_i \right|^2 = \sum_{n=1}^{N} |a_n|^2
$$
 (6.36)

If only ith port is excited and all other ports are matched terminated, all $a_n = 0$, $except a_i$, so that,

$$
\sum_{n=1}^{N} |S_{ni} a_i|^2 = \sum_{n=1}^{N} |a_i|^2
$$
 (6.37)

$$
\sum_{n=1}^{N} |S_{ni}|^2 = 1 = \sum_{n=1}^{N} S_{ni} S_{ni}^* \tag{6.38}
$$

Therefore, for a lossless junction

$$
\sum_{n=1}^{N} S_{ni} \cdot S_{ni}^* = 1
$$
 (6.39)

If all $a_n = 0$, except a_i and a_k ,

$$
\sum_{n=1}^{N} S_{nk} \cdot S_{ni}^* = 0 \; ; \; i \neq k \tag{6.40}
$$

In matrix notation, these relations can be expressed as

$$
\begin{aligned} \left[S^*\right] \left[S\right]_t &= \left[U\right] \\ \left[S^*\right] &= \left[S\right]_t^{-1} \end{aligned} \tag{6.41}
$$

Here $[U]$ is the identity matrix or unit matrix. A matrix $[S]$ for lossless network which satisfies the above three conditions $6.39 - 6.41$ is called a *unitary matrix*.

(d) Phase shift property

OT,

Complex S-parameters of a network are defined with respect to the positions of the port or reference planes. For a two-port network with unprimed reference planes 1 and 2 as shown in Fig. 6.2, the S-parameters have definite complex values

 $0¹$

148 Microwave Engineering

If the reference planes 1 and 2 are shifted outward to 1' and 2' by electric R 1. and $\phi_2 = \beta_2 l_2$, respectively, then the new wave varially If the reterence practice is a since β_1 and $\phi_2 = \beta_2 l_2$, respectively, then the new wave ψ_1 and $\phi_1 = \beta_1 l_1$ and $\phi_2 = \beta_2 l_2$, respectively, then the new wave ψ_3 are $\alpha_1 e^{j\phi_1}$, $b_1 e^{-j\phi_1}$, $a_2 e$

$$
[\mathcal{S}'] = \begin{bmatrix} e^{-j\phi_1} & 0 \\ 0 & e^{-j\phi_2} \end{bmatrix} [\mathcal{S}] \begin{bmatrix} e^{-j\phi_1} & 0 \\ 0 & e^{-j\phi_2} \end{bmatrix} \tag{6.4}
$$

This property is valid for any number of ports and is called the *phase* $\frac{s_{high}}{s_{high}}$ property applicable to a shift of reference planes.

2. Magic Tee

perme of ecctangulas wavequides makes 2 asme called. callineas arme (parte), (i.e) PORt 1 and port 2, while post 3 is called as H-Alm of sum part or Parallel port. port 4 is called as E-ARM or Difference post of series post. $2 -$ E-ARM ా H-Aem 4 Characteristics of E-H plane Tee = If a lignal of equal phase and magnitude Sent to part I and port 2, then the output at Port 4 is zero and the output at part 3 will be the additive of both the poets I and 2. * If a *tigral is sent* to post 4, E-aam then the power is divided Setueer Post 1 and 2 equally but in opposite ates phase, while there would be no putput at poet 3, Itene S34=0. a signal is fed at post 3, then the power $+1$ it diffided between poet land's equally while there would be no putput at post 4. $Hence S_{H3} = 0.$ * If a signal is fed at one of the colliseas poste, then there appeare no output at the other collisear port, as the E-arm produce a phace delay and the H-aam produce peoperties of E-H plane Tee Scottering matrix is of 4x4, as there are 4 possible inpute and 4 possible outpute.

 $\overline{2}$ Ζ $\begin{tabular}{|l|} \hline \textbf{Date:} & / \\ \hline \textbf{Page No:} \\ \hline \end{tabular}$ Flom eg (8) and (9) $3/3$ + $3/4$ $\sqrt{\frac{2}{t-1}}$ s_{2n} $=$ 54 $\overline{+}$ $\overline{+}$ 322 S_{11} $\overline{1}$ $S_{\mathbf{D}\mathbf{D}}$ S_{11} $29(8)$ and (13) is $e_{\sqrt{}}$ Values (12) weing \mathbb{R} $\frac{1}{1-\frac{1$ $|s_{11}|$ $\overline{\mathfrak{D}}$ \pm $\widehat{\sigma}$ s_{11} + s_{12} $=$ \vert - \vert CON \circ $-5v)$ S_1 2 $= 0$ \Rightarrow \mathcal{E} $= 0,$ Flom eg $\left(9\right)$ $\overline{\sigma}$ $\frac{1}{2} + \frac{1}{2} =$ $+$ s_{22} s_{11} s_{22} $|S_{11}|$ $\overline{\text{F}}$ \rightarrow (16) S_{22} $\frac{1}{2}$ $\frac{1}{2}$ $\frac{1}{2}$ $\frac{1}{2}$ $\frac{1}{2}$ ٥ post 1-and post 2 ale Peefectly matched $\overline{}$. to the junchion. The jurchion where all the foug parts are

3. Precision Phase Shifter

15.1 Precision phase shifter

A precisive rection of circular waveguide containing a lossless dielectric plate of This used to alled halfwave (180°) section. This section can be rotated over 360°
length 2l called halfwave (180°) section. This section can be rotated over 360° length in between two sections of circular to rectangular waveguide transitions each containing lossless dielectric plates of length *l* called quarterwave (90°) each commented at an angle of 45° with respect to the broad wall of the rectangu- $\frac{1}{2}$ waveguide ports at the input and output. The incident TE_{10} wave in the rectan- $\frac{1}{\text{gular}}$ metric becomes a TE_{11} wave in the circular guide. The halfwave section $\frac{1}{2}$ produces a phase shift equal to twice its rotation angle θ with respect to the quarterwave section. The dielectric plates are tapered through a length of quarter wavelength at both ends for reducing reflection due to discontinuity.

The principle of operation of the rotary phase shifter can be explained as follows. The $T\hat{E}_{11}$ mode incident field E_i in the input quarterwave section can be decomposed into two transverse components, one E_1 , polarised parallel and other, E_2 perpendicular to quarterwave plate. After propagation through the quarter wave plate these components are

$$
E_1 = E_i \cos 45^\circ e^{-j\beta_1 l} = E_o e^{-j\beta_1 l} \tag{6.86}
$$

$$
E_1 = E_t \cos \theta
$$

\n
$$
E_2 = E_t \sin 45^\circ e^{-j\beta_2 l} = E_o e^{-j\beta_2 l}
$$
\n(6.87)

where, $E_o = E/\sqrt{2}$. The length *l* is adjusted such that these two components will have equal magnitude but a differential phase change of $(\beta_1 - \beta_2)$ $t \ge 90^\circ$. Therefore, after propagation through the quarterwave plate these field components become (6.88)

$$
E_1 = E_o e^{-j\beta_1 t}
$$
 (6.89)

$$
E_{\rm g} = iE_{\rm g} e^{-j\beta_1 l} = jE_1 = E_1 e^{j\pi l/2}
$$

Thus the quarter wave sections convert a linearly polarised TE_{11} wave to a circullarly polarised TE_{11} l_{arly} polarised wave and vice-versa.

After emergence from the halfwave section, the field components parallel and perpendicular to the halfwave plate can be represented as

$$
E_3 = (E_1 \cos \theta - E_2 \sin \theta) e^{-j2\beta_1 l} = E_0 e^{-j\theta} e^{-j3\beta_1 l}
$$
 (6.90)

$$
E_4 = (E_2 \cos \theta + E_1 \sin \theta) e^{-j2\beta_2 l} = E_0 e^{-j\theta} e^{-j3\beta_1 l} e^{-j\pi/2}
$$
 (6.91)

since.

$$
2(\beta_1 - \beta_2)l = \pi \quad \text{or} \quad -2\beta_2 l = \pi - 2\beta_1 l \tag{6.92}
$$

 $1.023 - 1.2$

After emergence from the halfwave section the field components E_3 and E_4 may again be decomposed into two TE_{11} modes, polarised parallel and perpendicular to the output on the section dicular to the output quarterwave plate. At the output end of this quarterwave plate the field components parallel and perpendicular to the quarterwave plate
can be written as can be written as

$$
E_z = (E_{\text{max}} - 0.5) = 0.01 \times 10^{-3} \text{ (6.93)}
$$

Microwave Network Theory and Passive Devices 175 Therefore, the parallel component E_5 and perpendicular component E_6 at the output end of the quarterwave plate are equal in magnitude and in phase to pro-
output resultant field which is a linearly pole in magnitude and in phase to pro- $\frac{\partial u}{\partial u}$ a resultant field which is a linearly polarised TE_{11} wave

$$
E_{\text{out}} = \sqrt{2} E_o e^{-i2\theta} e^{-j4\beta_1 l}
$$

= $E_i e^{-j2\theta} e^{-j4\beta_1 l}$ (6.95)

having the same direction of polarisation as the incident field E_i with a phase having of $2\theta + 4\beta_1 l$. Since θ can be varied and $4\beta_1 l$ is fixed at a given frequency change of θ with the obtained by rotating the halfwave plate $\frac{1}{2}$ and $\frac{1}{2}$ is through an angle of θ with respect to the quarterwave plates.)

4. (i)

Example 6.3 A 20 mW signal is fed into one of collinear port 1 of a lossless
Example σ -junction. Calculate the power dells μ ² μ -plane *T*-junction. Calculate the power delivered through each port when $n₀$
 $n₀$ ports are terminated in matched load.

Solution

Since ports 2 and 3 are matched terminated, $a_2 = a_3 = 0$, $S_{11} = 1/2$. The total effective power input to port 1 is

$$
P_1 = |a_1|^2 (1 - |S_{11}|^2)
$$

= 20 (1 - 0.5²) = 15 mW

The power transmitted to port 3 is

$$
P_3 = |a_1|^2 |S_{31}|^2
$$

= 20 × (1/ $\sqrt{2}$)² = 10 mW

The power transmitted to port 2 is

$$
P_2 = |a_1|^2 |S_{21}|^2
$$

= 20 × (1/2)² = 5 mW.

Therefore, $P_1 = P_2 + P_2$

 1.1×10^{-1}

6.4.2 Coaxial Connectors and Adapters $\sqrt{6.4.2}$ Coaxial Connectors and *Nuar*
Coaxial cables are terminated or connected to other shield makes a 360 degree by Constal cables are terminated or connected The outer shield makes a 360 degree by
means of shielded standard connectors. The outer shield makes a 360 degree ex Coaxial capies are standard connectors. The olding integrity. These connectors means of shielded standard connectors, shielding integrity. These connectors $\frac{c_2}{c_3}$ means of shielded standard joint to maintain shield means or since to interest to maintain since and the cable diameter s are tremely low impedance joint to maintain since and the cable diameter. Comparison of various types depending on the frequency N (male/female), BNC (m tremely now the pending on the trequency condition (male/female), BNC (male/female), and the property of various types depending on the trequency N (male/female), and N and N and N and N (sexiless), etc. Adapter or various of the
monly used microwave connectors are cyproducities, having different connectors,
TNC (male/female), APC (sexless), etc. Adapters, having different connectors at TNC (male/female), APC (sextess), etc. the contraction between two different ports in the two ends, are also made for interconnection between two different ports in a the two ends, are also made for intercommending of these connectors and $_{\text{and} \text{ad}_{\text{ap}}\text{at}}$ microwave system. The basic schematic diagrams of these connectors and $_{\text{ad}_{\text{ap}}\text{at}}$ microwave system. The basic scientified of N (Navy) connector is 50 and 75 ohms con-
ers are shown in Fig. 6.6. The type N (Navy) connector is 50 and 75 ohms coners are shown in Fig. 6.6. The type is virtually applications during World W_{or} to the nector which was designed for military system applications during World W_{ar} [1] nector which was designed to minimally be in the frequency range of $1-\frac{18}{18}$ GHz
This is suitable for flexible or rigid cables in the frequency range of $1-\frac{18}{18}$ GHz This is suitable for flexible or used suitable for 0.25 inch 50 ohm or 75 oh_{n}
The BNC (Bayonet Navy Connector) is suitable for 0.25 inch 50 ohm or 75 oh_{n} The BNC (Bayonet Navy Composite) TNC (Threaded Navy Connector) is $\frac{1}{3}$ oh_{liq} flexible cables used up to 1 GHz. The TNC (Thread to make firm contractor) is $\frac{1}{3}$ $\frac{1}{3}$ flexible cables used up to 1 Oriental to make firm contact in the BNC, except that, the outer conductor has thread to make firm contact in the BNC, except that, the other contains leakage at higher frequencies. These connectors are used up to 12 GHz.

The SMA (Sub-Miniature A) connectors are used for thin flexible or semirigid cables. The higher frequency is limited to 24 GHz because of generation of higher order modes beyond this limit. All the above connectors can be of male $_{0}$ female configurations except the APC-7(Amphenol Precision Connector-7 mm) which provides coupling without male or female configurations. The APC-7 $_{154}$ very accurate 50 ohm, low VSWR connector which can operate up to 18 GHz.

Coaxial connectors and adapters Fig. 6.6

Another APC-3.5 connector is a high precision 50 ohm, low VSWR connector which can be either the male or female and can operate up to 34 GHz. It can mate with the oppositely sexed SM connector. Table 6.2 shows the type, dielectric in mating space and impedance of some of the above standard connectors.

11-1-1 Characteristic Impedance of Microstrip Lines

Microstrip lines are used extensively to interconnect high-speed logic circuits in digital computers because they can be fabricated by automated techniques and they provide the required uniform signal paths. Figure 11-1-1 shows cross sections of a microstrip line and a wire-over-ground line for purposes of comparison.

In Fig. 11-1-1(a) you can see that the characteristic impedance of a microstrip

Figure 11-1-1 Cross sections of (a) a microstrip line and (b) a wire-over-ground line.

line is a function of the strip-line width, the strip-line thickness, the distance between the line and the ground plane, and the homogeneous dielectric constant of the board material. Several different methods for determining the characteristic impedance of a microstrip line have been developed. The field-equation method was employed by several authors for calculating an accurate value of the characteristic impedance [3 to 5]. However, it requires the use of a large digital computer and is extremely complicated. Another method is to derive the characteristic-impedance equation of a microstrip line from a well-known equation and make some changes [2]. This method is called a *comparative*, or an *indirect*, method. The well-known equation of the characteristic impedance of a wire-over-ground transmission line, as shown in Fig. $11-1-1(b)$, is given by

$$
Z_0 = \frac{60}{\sqrt{\epsilon}} \ln \frac{4h}{d} \qquad \text{for } h \ge d \tag{11-1-1}
$$

where ϵ_r = dielectric constant of the ambient medium

 $h =$ the height from the center of the wire to the ground plane

 $d =$ diameter of the wire

If the effective or equivalent values of the relative dielectric constant ϵ_r of the ambient medium and the diameter d of the wire can be determined for the microstrip line, the characteristic impedance of the microstrip line can be calculated.

5.

Effective dielectric constant ϵ_{re} **.** For a homogeneous dielectric medium, the propagation-delay time per unit length is

$$
T_d = \sqrt{\mu \epsilon} \tag{11-1-2}
$$

where μ is the permeability of the medium and ϵ is the permittivity of the medium. In free space, the propagation-delay time is

$$
T_{df} = \sqrt{\mu_0 \epsilon_0} = 3.333 \text{ ns/m} \text{ or } 1.016 \text{ ns/ft} \qquad (11-1-3)
$$

where

$$
\mu_0 = 4\pi \times 10^{-7} \text{ H/m, or } 3.83 \times 10^{-7} \text{ H/ft}
$$

\n $\epsilon_0 = 8.854 \times 10^{-12} \text{ F/m, or } 2.69 \times 10^{-12} \text{ F/ft}$

In transmission lines used for interconnections, the relative permeability is 1. Consequently, the propagation-delay time for a line in a nonmagnetic medium is

$$
T_d = 1.106 \sqrt{\epsilon_r} \qquad \text{ns/ft} \tag{11-1-4}
$$

The effective relative dielectric constant for a microstrip line can be related to the relative dielectric constant of the board material. DiGiacomo and his coworkers discovered an empirical equation for the effective relative dielectric constant of a microstrip line by measuring the propagation-delay time and the relative dielectric constant of several board materials, such as fiberglass-epoxy and nylon phenolic [6].

Transformation of a rectangular conductor into an equivalent circular **conductor.** The cross-section of a microstrip line is rectangular, so the rectangular conductor must be transformed into an equivalent circular conductor. Springfield discovered an empirical equation for the transformation [7]. His equation is

$$
d = 0.67w \left(0.8 + \frac{t}{w}\right) \tag{11-1-6}
$$

where $d =$ diameter of the wire over ground

- $w =$ width of the microstrip line
- $t =$ thickness of the microstrip line

The limitation of the ratio of thickness to width is between 0.1 and 0.8, as indicated in Fig. 11-1-3.

Characteristic impedance equation. Substituting Eq. $(11-1-5)$ for the dielectric constant and Eq. $(11-1-6)$ for the equivalent diameter in Eq. $(11-1-1)$ vields

$$
Z_0 = \frac{87}{\sqrt{\epsilon_r + 1.41}} \ln \left[\frac{5.98h}{0.8w + t} \right] \qquad \text{for } (h < 0.8w) \tag{11-1-7}
$$

Figure 11-1-13 Relationship between a round conductor and a rectangular conductor far from its ground plane. (After H. R. Kaupp [2]; reprinted by permission of IEEE, Inc.)

where ϵ_r = relative dielectric constant of the board material

 $h =$ height from the microstrip line to the ground

- $w =$ width of the microstrip line
- $t =$ thickness of the microstrip line

Equation $(11-1-7)$ is the equation of characteristic impedance for a narrow microstrip line. The velocity of propagation is

$$
v = \frac{c}{\sqrt{\epsilon_{re}}} = \frac{3 \times 10^8}{\sqrt{\epsilon_{re}}} \qquad m/s \qquad (11-1-8)
$$

The characteristic impedance for a wide microstrip line was derived by Assadourian and others [8] and is expressed by

$$
Z_0 = \frac{h}{w} \sqrt{\frac{\mu}{\epsilon}} = \frac{377}{\sqrt{\epsilon_r}} \frac{h}{w} \quad \text{for } (w \gg h)
$$
 (11-1-9)

6. (i) Radiation Pattern

 \overline{z} classmate Date Page BACIC ANTENNA PARAMETERS (1) Radiation pattern the adative field strength x plot of θ the Sadio wave emitted the artenna different angles. Field potters \mathbf{z} \mathbf{I} Mais lobe age Mais Lobe $Q = 0$ E_{ϕ} Poster Field in of disections yEro Jobe $\tilde{\omega}$ Antenna ∞ У $B950$ Figure => Anterna field pattern Φ = ρ Poivel pattern obe (OR) mais beam Main mais tobe $Q\dot{x}$ $\rho(\Theta)$ Pawea beamwridth (HPSy) $H \alpha$ mills BRAM with between Airst Mit $\pmb{\cdot}$ $, 5$ (ESguse en Antenna $\mathcal{S}_{\mathcal{A}}$, \mathcal{S} \overline{X} Mithy Power partien in

 $\frac{1}{2}$ d8 patters Idal acom \circ d_B Start State Minoh Std e haber $-3d8$ Matt Nwh Mull Jī $d\phi$ っゃ Figure 3 -> Antenna patteine in Sectagular Gooldinates and decisel scale Fig (1) shows a field patters violere & is Proportional to the field intensity at a creatain distance slam the antenna in the disection of + The pattern has its mais-lobe maximum is the Z dierection (a =0) with minor lober (side and back) in other directions. * Between the laster are nulls in the directions of zees, a minimum radiation. * To completely specify the Radiation patters Laguires theee patterne:

 $\frac{1}{2}$ classmate O Component of the electric field
a function of the grand of a (i) The E_{0} (a, b) V/m Component of the electric (ii) The a function of the angles a and The phases of these field as a function of
the angles a and d or So (0,0) and So (0,0)
(radians or degrees) (iii) The Normalized field patteen - dividing field component by its mainum value. It mallonun value of unity. Normalized field patters for the 0 Component of the electric tield is given $by₁$ E_{p} $\left\lfloor \omega_{1} \right\rfloor$ $E_{\theta}(\theta, \phi)$ Patterna are measured There at tag Canditions.

* Patterne may also be expected in teame of * Patterne may also be supplement the power per unit area (0A) poynting
the power per unit area (0A) poynting
vector S (0, 0) at a certain distance from the antenna. * Normalized pouver pattein à gives by, $P_{0}(\omega,\phi)=8(0.00)$ (dissensionness) $s(\theta, \phi)$ mar (obere $S(\theta, \phi)$ = paynting vectors $\mathbb{E}_{\mathbf{a}}\left(\mathbf{b},\mathbf{b} \right) + \mathbf{e}_{\mathbf{y}}^{2}\left(\mathbf{b},\mathbf{b} \right) + \mathbf{e}_{\mathbf{y}}^{2}\left(\mathbf{b},\mathbf{b} \right)$ $S(0,0)_{max}$ = maximum value of $S(0,0)$ w/m^2 Zo = intérior dic impedance of free space $= 377$ Ω . $\frac{1}{2} \sum_{i=1}^{n} \frac{1}{2} \sum_{i=1}^{n$ + Any of these field of power, patterne -> 3-dimensional Spheeical (Figue 1) principal place potters - Two cute at light anglee (x2 and y2 place) Figure, 2 $fig(3) \rightarrow In$ decibel scale $g_{\mathbf{p}}(9,9)$

(ii) Beam Area

스 classmate Date Page, (i) Beam Alea ah Beam Solid Angle ALC agate Alla of Sphere Center $\overline{\mathbf{c}}$ Solid Cubberded alea A The arc of a circle as seen from the center of the circle subtende as angle-From fig (1), the arc logger or subtends the U. cinque a. The total angle in the circle & 211 eachant and the tobal arc length is 2118. \cdot . An area A of the escrapace of a sphere as been from the center of the sphere Subtende a solid angle 2. * The total solid angle subtended by the Sphere is for steeradiane of square sadiane, abbreviated sr.

 \overline{a} classmate Date Page The the strip alea Θ σ extending the Δ \mathcal{L} constant angle a given Petts sina) (r da). 10.9 Trotegrating this' Value \sim y i eleve "the σ ϕ π alla \circ sthere. π $Sphere = 2TT\$ Alea عمثه \cdot T $\cos\theta$ π $\overline{1}$ \overline{c} \cdot \cdot \cdot $= 2\pi\delta$ \rightarrow (2) $\sin 4 =$ Where $4T$ $\hat{\mu}$ solid angle stubberded is Steladiane. a sphele Thill Solid agle & treadiso of sphe 1.71 806 au Hei 3282-806427 Steradiane = -1.4π

equivalent to the same solid angle subterded
by the spherical cap of the come-shaped
(triangular Close section) pattels.

deecripe estid a tten angle Car is teene ately anglee \sim Inte ha $\frac{1}{2}$ the p_{α} \overline{a} 04 Peio cipa top the two ے من $\hat{\omega}$ $\frac{b}{f}$ given al Planee $=$ O HP $9HP$ SL_{1} \cdot (9_{HP} are power the and \mathcal{L} $HPSW$ the Ω or B_{2} ni id Plane tabel being ne minge leg

(iii) **Directivity**

Therefore, the second term of the two terms are

\n
$$
2 = 1
$$
\n
$$
\frac{2}{4\pi} \int \frac{1}{5(a_1b)mx} \cdot \frac{1}{5(a_1b)mx} \
$$

the effect of minor Sobel Neglecting \cdot $\frac{1}{1-t}$ $4T$ $D =$ $\overline{\mathcal{M}}$ è $4!;000$ $4-F$ $\overline{\mathbf{r}}$ D \approx Φ HP Φ HP $-0 + p 0 4 + p$ $\overline{}$ $, • •$ degrees 253 square laceias $=$ μ $4F^2$ 211000 u $\epsilon_{\rm c}^{\rm obs}$, $\epsilon_{\rm c}$ Where 444 Power beamwidth in ha $\overline{}$ plane, radian \sim <u>beamwidth is of plane</u> Power $\phi_{\rm HP}$ Pasea beamwisth in a place, degree O_{HP}° $\boldsymbol{\omega}$ $\phi_{\rm H}$ ° Ξ

(v) Beam Efficiency

(1)
$$
Bernerpericency
$$

\nThe (both half) beam data $3-a$ (beam solid
\n cm) (onelit of the main beam and
\n Sm plus the main hole area $3m$. Thus,
\n $3a = 3-m + 3$ m 300
\nThe both 4 the main beam area to
\nthe total beam node. 4, called the beam
\n984 (the total beam, 4, called the beam
\n984 (the total beam area 4 , called the beam
\nthe total beam area 4 called the
\n $Em = \frac{32m}{320} = 8+20+8$ (acto9)
\n $Am = \frac{32m}{320} = 8+20+8$ (acto9)
\n $20+6m = 1$ (b)

7. **(i) Friis Transmission Formula**

classmate Date Page FRIIS TRANSMISSION FORMULA Receiving gearinating error Aer Act $\mathbf{1}$ \cdot 4 \sim \sim 12 Flaremitter : Receiver الأكاليات formula "givee the power received Thie sadio communication cis cuit. prea a \bullet a Power the teamerities T feel Let fearemitting antenna of effective $\mathfrak{t}\sigma$ σ dietance 8, 6 Aet \sim Pawee At effective Leccining antenna \cdot \cdot Aperture Aer intercepte some of the Power Radiated by the transmitting articina delivere it to the Receiver Alsumption -> Thansmitting antenna $\mathcal{L}_{\mathcal{A}}$ is otropsa, the power per voit area at the Receiving anterna. $=\frac{\rho_t}{4\pi r^2}$ \Rightarrow θ

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8. Losses in Microstrip Lines

11-1-2 Losses in Microstrip Lines

Microstrip transmission lines consisting of a conductive ribbon attached to a dielectric sheet with conductive backing (see Fig. 11-1-4) are widely used in both microwave and computer technology. Because such lines are easily fabricated by printed-circuit manufacturing techniques, they have economic and technical merit.

The characteristic impedance and wave-propagation velocity of a microstrip line was analyzed in Section 11-1-1. The other characteristic of the microstrip line is its attenuation. The attenuation constant of the dominant microstrip mode depends on geometric factors, electrical properties of the substrate and conductors, and on the frequency. For a nonmagnetic dielectric substrate, two types of losses occur in the dominant microstrip mode: (1) dielectric loss in the substrate and (2) ohmic skin loss in the strip conductor and the ground plane. The sum of these two losses may be expressed as losses per unit length in terms of an attenuation factor α . From ordinary transmission-line theory, the power carried by a wave traveling in the positive z direction is given by

$$
P = \frac{1}{2} VI^* = \frac{1}{2}(V_+e^{-\alpha z}I_+e^{-\alpha z}) = \frac{1}{2}\frac{|V_+|^2}{Z_0}e^{-2\alpha z} = P_0e^{-2\alpha z} \qquad (11-1-10)
$$

where $P_0 = |V_+|^2/(2Z_0)$ is the power at $z = 0$.

The attenuation constant α can be expressed as

$$
\alpha = -\frac{dP/dz}{2P(z)} = \alpha_d + \alpha_c \qquad (11-1-11)
$$

where α_d is the dielectric attenuation constant and α_c is the ohmic attenuation constant.

The gradient of power in the z direction in Eq. $(11-1-11)$ can be further expressed in terms of the power loss per unit length dissipated by the resistance and the power loss per unit length in the dielectric. That is,

$$
-\frac{dP(z)}{dz} = -\frac{d}{dz}(\frac{1}{2}VI^*)
$$

= $\frac{1}{2}\left(-\frac{dV}{dz}\right)I^* + \frac{1}{2}\left(-\frac{dI^*}{dz}\right)V$
= $\frac{1}{2}(RI)I^* + \frac{1}{2}\sigma V^*V$
= $\frac{1}{2}|I|^2R + \frac{1}{2}|V|^2\sigma = P_c + P_d$ (11-1-12)

where σ is the conductivity of the dielectric substrate board.

Substitution of Eq. $(11-1-12)$ into Eq. $(11-1-11)$ results in

$$
\alpha_d \simeq \frac{P_d}{2P(z)} \qquad \text{Np/cm} \tag{11-1-13}
$$

and

$$
\alpha_c \simeq \frac{P_c}{2P(z)} \qquad \text{Np/cm} \tag{11-1-14}
$$

Dielectric losses. As stated in Section 2-5-3, when the conductivity of a dielectric cannot be neglected, the electric and magnetic fields in the dielectric are no longer in time phase. In that case the dielectric attenuation constant, as expressed in Eq. $(2-5-20)$, is given by

$$
\alpha_d = \frac{\sigma}{2} \sqrt{\frac{\mu}{\epsilon}} \qquad \text{Np/cm} \tag{11-1-15}
$$

where σ is the conductivity of the dielectric substrate board in U/cm . This dielectric constant can be expressed in terms of dielectric loss tangent as shown in Eq. $(2-5-17)$:

$$
\tan \theta = \frac{\sigma}{\omega \epsilon} \tag{11-1-16}
$$

Then the dielectric attenuation constant is expressed by

$$
\alpha_d = \frac{\omega}{2} \sqrt{\mu \epsilon} \tan \theta \qquad \text{Np/cm} \qquad (11-1-17)
$$

Since the microstrip line is a nonmagnetic mixed dielectric system, the upper dielectric above the microstrip ribbon is air, in which no loss occurs. Welch and Pratt [9] derived an expression for the attenuation constant of a dielectric substrate. Later on, Pucel and his coworkers [10] modified Welch's equation [9]. The result is

$$
\alpha_d = 4.34 \frac{q\sigma}{\sqrt{\epsilon_{re}}} \sqrt{\frac{\mu_0}{\epsilon_0}}
$$

= 1.634 × 10³ $\frac{q\sigma}{\sqrt{\epsilon_{re}}}$ dB/cm (11-1-18)

In Eq. (11-1-18) the conversion factor of 1 Np = 8.686 dB is used, ϵ_{re} is the effective dielectric constant of the substrate, as expressed in Eq. $(11-1-5)$, and q denotes the dielectric filling factor, defined by Wheeler [3] as

$$
q = \frac{\epsilon_{re} - 1}{\epsilon_r - 1} \tag{11-1-19}
$$

We usually express the attenuation constant per wavelength as

$$
\alpha_d = 27.3 \left(\frac{q \epsilon_r}{\epsilon_{re}} \right) \frac{\tan \theta}{\lambda_s} \qquad \text{dB}/\lambda_s \qquad (11-1-20)
$$

where $\lambda_g = \frac{\lambda_0}{\sqrt{\epsilon}}$ and λ_0 is the wavelength in free space, or $\lambda_g = \frac{c}{f \sqrt{\epsilon_{re}}}$ and c is the velocity of light in vacuum.

If the loss tangent, tan θ , is independent of frequency, the dielectric attenuation per wavelength is also independent of frequency. Moreover, if the substrate conductivity is independent of frequency, as for a semiconductor, the dielectric attenuation per unit is also independent of frequency. Since q is a function of ϵ , and w/h , the filling factors for the loss tangent $q\epsilon_n/\epsilon_{re}$ and for the conductivity $q/\sqrt{\epsilon_{re}}$ are also functions of these quantities. Figure 11-1-5 shows the loss-tangent filling factor against w/h for a range of dielectric constants suitable for microwave inte-

Figure 11-1-5 Filling factor for loss tangent of microstrip substrate as a function of w/h. (After R. A. Pucel et al. [10]; reprinted by permission of IEEE, $Inc.)$

grated circuits. For most practical purposes, this factor is considered to be 1. Figure 11-1-6 illustrates the product $\alpha_d \rho$ against w/h for two semiconducting substrates, silicon and gallium arsenide, that are used for integrated microwave circuits. For design purposes, the conductivity filling factor, which exhibits only a mild dependence on w/h , can be ignored.

In a microstrip line over a low-loss dielectric substrate, the **Ohmic losses.** predominant sources of losses at microwave frequencies are the nonperfect conductors. The current density in the conductors of a microstrip line is concentrated in a sheet that is approximately a skin depth thick inside the conductor surface and exposed to the electric field. Both the strip conductor thickness and the ground plane thickness are assumed to be at least three or four skin depths thick. The current density in the strip conductor and the ground conductor is not uniform in the transverse plane. The microstrip conductor contributes the major part of the ohmic loss. A diagram of the current density J for a microstrip line is shown in Fig. 11-1-7.

Because of mathematical complexity, exact expressions for the current density of a microstrip line with nonzero thickness have never been derived [10]. Several researchers [8] have assumed, for simplicity, that the current distribution is uniform and equal to I/w in both conductors and confined to the region $|x| < w/2$. With this assumption, the conducting attenuation constant of a wide microstrip line is given by

Figure 11-1-6 Dielectric attenuation factor of microstrip as a function of w/h for silicon and gallium arsenide substrates. (After R. A. Pucel et al. [10]; reprinted by permission of IEEE, Inc.)

Figure 11-1-7 Current distribution on microstrip conductors. (After R. A. Pucel et al. [10]; reprinted by permission of IEEE, Inc.)

where
$$
R_s = \sqrt{\frac{\pi f \mu}{\sigma}}
$$
 is the surface skin resistance in Ω /square
\n
$$
R_s = \frac{1}{\delta \sigma} \text{ is } \Omega/\text{square}
$$
\n
$$
\delta = \sqrt{\frac{1}{\pi f \mu \sigma}} \text{ is the skin depth in cm}
$$

For a narrow microstrip line with $w/h \le 1$, however, Eq. (11-1-21) is not applicable. The reason is that the current distribution in the conductor is not uniform, as assumed. Pucel and his coworkers [10, 11] derived the following three formulas from the results of Wheeler's work [3]:

In addition to the conductor and dielectric losses, mi-**Radiation losses.** crostrip line also has radiation losses. The radiation loss depends on the substrate's thickness and dielectric constant, as well as its geometry. Lewin [12] has calculated the radiation loss for several discontinuities using the following approximations:

- 1. TEM transmission
- 2. Uniform dielectric in the neighborhood of the strip, equal in magnitude to an effective value
- 3. Neglect of radiation from the transverse electric (TE) field component parallel to the strip
- 4. Substrate thickness much less than the free-space wavelength

Figure 11-1-8 Theoretical conductor attenuation factor of microstrip as a function of w/h. (After R. A. Pucel et al. [10]; reprinted by permission of IEEE, Inc.)

Lewin's results show that the ratio of radiated power to total dissipated power for an open-circuited microstrip line is

$$
\frac{P_{\rm rad}}{P_t} = 240\pi^2 \left(\frac{h}{\lambda_0}\right)^2 \frac{F(\epsilon_{re})}{Z_0} \tag{11-1-28}
$$

where $F(\epsilon_{re})$ is a radiation factor given by

$$
F(\epsilon_{re}) = \frac{\epsilon_{re} + 1}{\epsilon_{re}} - \frac{\epsilon_{re} - 1}{2\epsilon_{re}\sqrt{\epsilon_{re}}} \ln \frac{\sqrt{\epsilon_{re} + 1}}{\sqrt{\epsilon_{re} - 1}} \tag{11-1-29}
$$

in which ϵ_{re} is the effective dielectric constant and $\lambda_0 = c/f$ is the free-space wavelength.

The radiation factor decreases with increasing substrate dielectric constant. So, alternatively, Eq. (11-1-28) can be expressed as

$$
\frac{P_{\text{rad}}}{P_t} = \frac{R_r}{Z_0} \tag{11-1-30}
$$

where R_r is the radiation resistance of an open-circuited microstrip and is given by

$$
R_r = 240\pi^2 \left(\frac{h}{\lambda_0}\right)^2 F(\epsilon_{re})
$$
 (11-1-31)

The ratio of the radiation resistance R_r to the real part of the characteristic impedance Z_0 of the microstrip line is equal to a small fraction of the power radiated from a single open-circuit discontinuity. In view of Eq. $(11-1-28)$, the radiation loss decreases when the characteristic impedance increases. For lower dielectric-constant substrates, radiation is significant at higher impedance levels. For higher dielectricconstant substrates, radiation becomes significant until very low impedance levels are reached.